# Post-Mapping Transformations for Low-Power Synthesis †

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## Abstract

We propose a logic synthesis system that includes power optimization *after* technology mapping. Our approach is unique in that our post-mapping logic transformations take into account information on circuit delay, capacitance, arrival times, glitches, etc, to provide much better accuracy than previously proposed technology-independent power optimization methods. By changing connections in a mapped circuit that was earlier restructured for lower switching activity, we achieve power improvements up to 59% in case of area-optimized circuits and 38% in delay-optimized circuits. The average power reduction is 15% and 13% for the above cases respectively, with reductions also in area and delay. The transformations are based on the *transition density* model of circuit switching activity and the concept of *permissible logic functions*. The techniques presented here are applicable equally well to both synchronous and asynchronous circuits. The power measurements are done under a general delay model.

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# 1. Introduction

The high device count and clock frequency of modern ICs has made power dissipation of VLSI chips a major consideration during chip design. Hence the need for low-power logic synthesis techniques to aid in the automatic design of low-power chips. While it is important to attack the synthesis problem at all levels, in this paper we focus on the *logic synthesis* phase and propose a new algorithm for optimization in a post-technology mapping step that achieves lower power circuits on a variety of test cases.

In the popular CMOS technology, the power dissipated by logic gates is almost entirely due to the logic transitions. Thus the power-dissipation depends on the *switching activity* inside the circuit, which in turn depends on the *input switching pattern* and the *specific implementation* of the circuit. This complicates the low-power synthesis problem, since (*i*) exact input signals may not be known during the design phase and (*ii*) the traditional synthesis techniques of optimizing a technology independent circuit model become inadequate.

To get around the input pattern-dependence problem, one can use probabilities to describe the set of *all possible logic signals*. Specifically, we will use a measure of switching activity, called the *transition density* [1], that can be efficiently evaluated without requiring *exact* information about the primary input signals. In order to automatically find a low-power implementation of a circuit design, we propose a new power-reducing logic transformation to be applied after the technology-mapping stage of logic synthesis. This transformation is proposed to augment any power optimization effort that is carried out at the technology-independent phases of logic synthesis. In particular, we demonstrate the effectiveness of our post-mapping procedure on the circuits that are restructured for minimum switching activity at the *technology decomposition* stage.

The transition density at a node $x$ in the circuit is the *average number of logic transitions per second* at that node, denoted by $D(x)$. If $D(x_i)$ is the transition density at the output $x_i$ of the $i$th logic gate, then the average power consumed by the circuit is:

$$P_{av} = \sum_{i=1}^{n} \frac{1}{2} V_{dd}^2 C_i D(x_i)$$

where $C_i$ is the total capacitance at that gate output.

In order to lower the circuit power, one would like to automatically design the circuit in such a way as to either reduce $n$, or to reduce the values $C_i D(x_i)$. Reducing $n$ is equivalent to the traditional synthesis concern of reducing area. Reducing the $C_i D(x_i)$ terms, however, is strictly a power concern and requires new synthesis algorithms. Even though gate area might be a measure of $C_i$, minimizing area does not necessarily minimize the power because it is the *cross-terms* $C_i D(x_i)$ that have to be minimized, and not only the $C_i$ terms.

As we will review in the next section, most existing low-power synthesis techniques optimize a technology-independent model of the circuit in which the gates are assumed to have zero-delay. This, we will show, is inadequate for low-power synthesis. Our approach is unique in that we take the circuit technology into account and make detailed considerations of delay, capacitance, rise/fall times, glitches, etc. in our procedure to minimize the $C_i D(x_i)$ terms. Thus, we take into account the so-called *glitch power*, which is an important feature of our approach and differentiates this work from others. Briefly, the glitch power is a component of the power dissipation that is due to spurious unplanned-for transitions inside a logic circuit. These transitions, or *glitches*, arise from the unequal delays of reconvergent paths that typically exist inside the circuit. Throughout this work, we will assume that we are dealing with a combinational circuit block which is embedded in a synchronous sequential circuit. For more details on glitch power and other related issues of power estimation, the reader is referred to [2].

We will make use of the concept of permissible functions [3], which we briefly review in the appendix. In Section 2 we give a short review of previous work in this area and in Section 3 an overview of our system. Details of the proposed algorithm are given in Section 4 and the experimental results are reported in Section 5. Summary and conclusions are given in Section 6.

## 2. Background

The work in [4] considers several strategies at the technology, architectural and circuit design levels, that can be adopted for optimizing power in VLSI circuits. While reduction of power supply voltage and power-down strategies are already common in industry, additional power reduction can be obtained at the logic optimization and technology-binding phases of logic synthesis.

There has been much recent work on logic synthesis for low power. Unfortunately, most proposed techniques have dealt with a technology-independent model of the logic circuit, based on the use of a zero-delay timing model for logic gates. We briefly cite some of this previous work and then give a simple example to illustrate that optimization with no regard to delay is not adequate for low-power synthesis. In contrast to these techniques, our optimization procedure includes transformations that are applied after technology mapping, and makes use of the circuit delay information.

The work in [5] considers the switching activity contribution of kernel intersections while extracting new nodes as factors of other nodes. They use transition density [1] to evaluate the node power. Another approach [6] uses selective collapsing of nodes on non-critical paths, timing optimization and node minimization, as strategies to optimize power during the logic

optimization phase. The work in [7] presents a technique to minimize the zero-delay power by changing the Boolean function at the nodes. The problem of power minimization at the technology-binding phase (technology decomposition and technology mapping) of logic synthesis has also been actively addressed [8–11].

The power computed under a zero-delay assumption (or simply, zero-delay power) is not an appropriate guiding measure for low-power optimization. This is due to the fact that an optimization step that improves zero-delay power does not provide a guarantee about the improvement of the total power. To prove this point, we show in Table 1 below two different implementations of a reasonably-sized benchmark circuit, *vda*. The second implementation dissipates 35.4% more power than the first implementation, despite the fact that its zero-delay power is 2.8% less and area is 1.9% less. Both these implementations had the same optimization route up-to and including technology mapping, but differed in their post-mapping optimization.

TABLE 1

EXAMPLE OF OPTIMIZATION LEADING TO FAVORABLE ZERO-DELAY POWER BUT WORSE TOTAL POWER

| Implementation | #Gates | #Connections | Area | ZDPower | TotalPower | Delay |
|---|---|---|---|---|---|---|
| A | 469 | 948 | 727552 | 412.993 | 536.083 | 17.476nS |
| B | 459 | 933 | 713632 | 401.472 | 725.661 | 19.450nS |

Finally, some techniques have been proposed for technology-dependent optimization, along the lines of transistor/gate sizing. Thus [12] proposes resizing of gates on non-critical paths, taking false paths into account. Resizing is of course a viable optimization strategy, but we will show that there is scope for more optimization by applying logic transformations that make use of the delay and functionality information.

## 3. System Overview

A schematic overview of our low-power logic synthesis system, called *LogicPower* is shown in Fig. 1. The solid lines show the current implementation.

The main synthesis flow is the vertical downward path on the right. The three blocks of LOGIC MINIMIZATION, TECHNOLOGY DECOMPOSITION, and TECHNOLOGY MAPPING represent the traditional SIS synthesis flow [13]. We have found scope for optimization in the technology decomposition step, as reported in [11]. The technology decomposition algorithm uses transition density as a measure of internal switching activity, and the density values are computed, in a separate block, as shown in the figure, using [1] and [14]. We have also added a post-mapping block, which is the subject of this paper, labeled GATE-LEVEL TRANSFORMATIONS in the figure. Post-mapping transformations have the potential

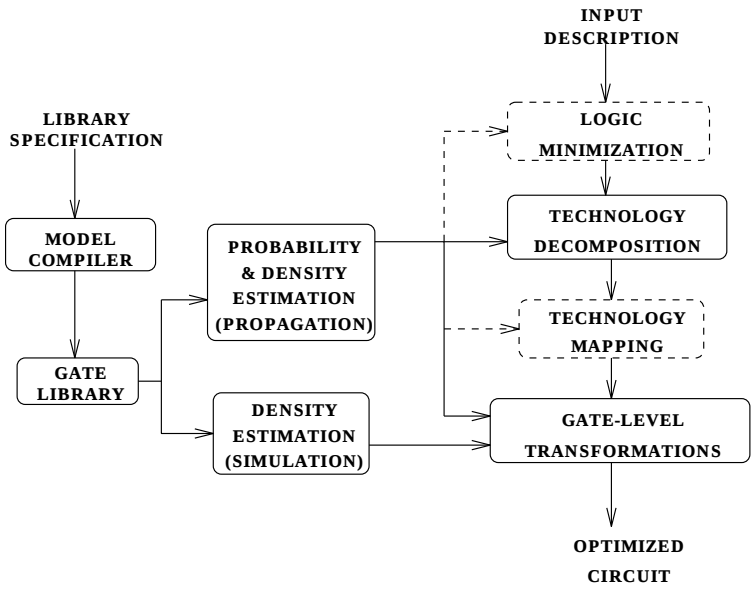


**Figure 1.** Overview of LogicPower.

for high-accuracy because they use information on the circuit delay, glitches, etc. These post-mapping transformations are unique to our approach.

In the remainder of this paper, we will discuss *cost functions* that make use of the delay information and are useful inside the optimization loop to determine the favorable moves. In addition to that, our algorithm also uses an accurate measure of power dissipation and the glitching component of power, based on [15], to guide the transformations and also to verify the final results. The power estimation uses a general delay gate level model and is accurate to within a user-specified error bound, with user-specified confidence. It takes into account fanout capacitance, rise/fall times, inertial delay and propagation delay.

The LOGIC MINIMIZATION and TECHNOLOGY MAPPING remain the same as in the MIS/SIS synthesis system.

## 4. Post-Mapping Transformation

We shall first explain the motivation for doing transformations after the technology mapping stage. Consider the SIS-style of optimizing a technology-independent network and later mapping it to a set of gates in a given technology, with the objective of minimizing the area/speed/power. Such an optimization process may give a circuit implementation that possesses one or both of the following undesirable features:

($i$) The switching consists of excessive glitches.

($ii$) Some nodes with very high switching activity are driving large loads.

Both of the above situations are undesirable for power and thus a post-mapping step that can rectify the above situation becomes useful. Besides, the performance of any power opti-

mization procedure depends heavily on the accuracy of power estimation and the availability of accurate information about the various circuit parameters that affect the power. These parameters are the gate capacitances, the amount of switching at the nodes, the glitching component of switching activity of the nodes, the arrival times of signals, and finally the propagation and inertial delays of the gates. As all these factors can be accurately assessed after the technology mapping step, it follows that power optimization can be done very effectively at the post-mapping stage.

Another favorable characteristic of post-mapping optimization is its ability to augment any power optimization done at the previous stages of synthesis. While the technology-independent optimizations are subject to the risk of being partly undone by the restructuring of the circuit due to subsequent steps of optimization, the technology-dependent post-mapping procedure suffers much less from such a risk.

The basic idea behind our post-mapping transformation is to change the connections configuration of the network such that:

($i$) Inputs of gates are driven from nodes with less transition density, instead of from nodes with higher transition density.

($ii$) The glitches at the output of gates are reduced.

($iii$) Any residual redundant gate or connection in the mapped circuit is removed.

These changes can be achieved by substituting the fanout connections of gates with connections from other gates, if such substitutions will decrease the total power dissipation in the network, provided the Boolean functions at the nodes remain correct. To determine which connections can substitute which, we use the concept of Permissible Functions [3].

To illustrate how this works, we refer to Fig. 2. Consider the fanout branch of node $f$ that is connected to the input of gate 2 (the *nand* gate). There may be other nodes in the circuit (other than $f$) which can be used to drive that same input of gate 2, without altering the functionality of the circuit. The Boolean functions at these other nodes are said to be *permissible* at $f$. Thus, we could disconnect $f$ from the input of gate 2 and instead connect some other circuit node to that input. Of course, this is a useful transformation only when it leads to lower power. As a side note, in the course of applying this transformation, if both the fanouts of $f$ get substituted by other nodes, then gate 1 can be eliminated.

This transformation has been referred to as *generalized gate substitution* and has been used with the objective of eliminating gates and/or connections [16]. We use this transformation, but in a different manner, for reducing power.

In the course of the transformation, we do not want the Boolean function at node $g$ to change, since that would alter the Boolean functions, and hence the zero-delay activity, of the nodes in its transitive fanout, and would have an unpredictable global effect on the circuit power. So we restrict the set of candidate substitutions for a connection to be such that the

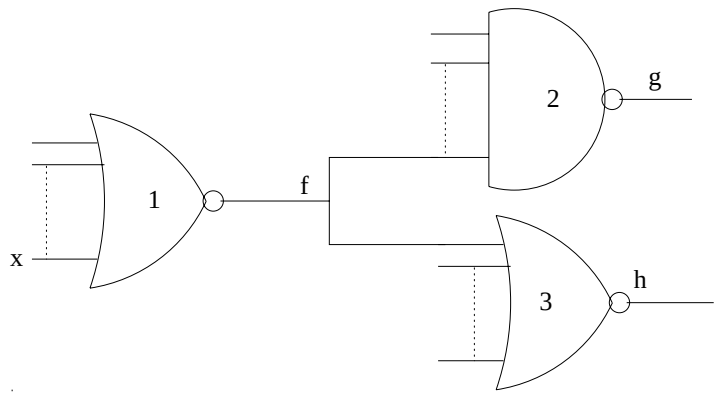


**Figure 2.** Example to illustrate the use of permissible functions.

output function of the gate driven by this connection does not change. We ensure this by using the *Locally-derived Set of Permissible Functions* [17] for the connection. Originally, LSPFs were used in synthesis [17], with the objective of speeding up the calculation of permissible functions, at the cost of sacrificing the optimality. The restriction that the immediate output function should not change is responsible for reducing the don't care space of the permissible functions to a smaller subset. In our approach, we take advantage of this restriction, as that is exactly what we wish to achieve, viz., preserving the Boolean functions at all the nodes in the network, so that the zero-delay activity of the nodes is well under control.

In order to substitute a connection $c_{ij}$ from gate $g_i$ to gate $g_j$, the procedure finds all the candidate nodes, $g_k$ which satisfy the following requirements:

($i$) $F(g_k) \epsilon LSPF(c_{ij})$

($ii$) Maximum arrival time of signal at $g_k$ is less than minimum arrival time of signal at $g_j$, or Level($g_k$) is less than or equal to Level($g_i$).

Condition ($i$) ensures that the Boolean functions at the nodes would remain the same and ($ii$) ensures that no feed-back loop is created, if $c_{ij}$ is substituted by a connection from $g_k$. Condition ($ii$) also helps to keep the overall delay affected less after the substitution. Among the various candidates (including $g_i$ itself) the one that would result in maximum power reduction is chosen to do the substitution. The strength of our procedure lies in the detailed consideration of the various parameters related to the modification of total power due to this substitution. We consider four contributions to the power saving, when a connection $c_{ij}$ from gate $g_i$ to gate $g_j$ can be substituted by a connection from node, $g_k$. They are described below.

### 4.1 Power Cost Function

We use a three-part cost function. If $x$ is a candidate node for substituting an input of a

gate, $Y$, then the *power cost* of using $x$ to drive $Y$ is given as:

$$PowerCost(x, Y) = LoadingCost(x, Y) + GlitchingCost_1(x, Y) + GlitchingCost_2(x, Y)$$

The *LoadingCost* term in the above considers the transition density of $x$ and the amount of load on $x$ due to the input capacitance of $Y$. The *GlitchingCost* terms consider the effect on total power due to the glitches at $x$, and due to the glitches at the other inputs of $Y$, respectively. The following four considerations explain how these three cost factors are calculated.

*4.1.1 Consideration of Loading:*

In Fig. 3., substituting the connection from $z$ to $Y$ by a connection from $x$ is attractive, if $D(x) < D(z)$. If this substitution is done, the capacitance load of the input pin of gate $Y$, $C_{in}(Y)$ will get shifted to node $x$. So, we take the first component of the power cost as the transition density of $x$, weighted by the additional capacitance it will have to drive, if the substitution takes place. That is:

$$LoadingCost(x, Y) = D(x) \times C_{in}(Y)$$

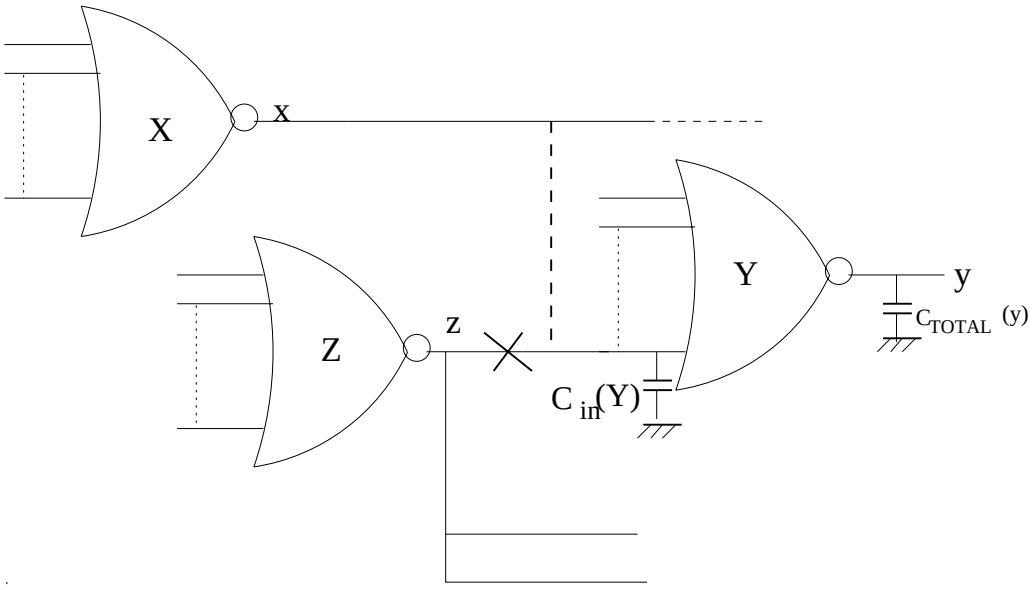


**Figure 3.** Considering Transition Density for Connection Substitution

*4.1.2 Consideration of Arrival Times with Glitches:*

Here we associate a cost with the amount of glitches present in a signal, as some or all of these glitches can pass through the gate to which this signal is made an input, causing power dissipation at that gate's output. We call this cost as $GlitchingCost_1$. If two or more

signals transition at the inputs of a gate at the same time or within a duration separated by the inertial delay of the gate, then at most only one transition will occur at the output of the gate. This suggests that what is crucial in passing the glitches of the input signals through a gate is the non-simultaneity in the switching of these input signals. To evaluate the various candidate signals for substituting an input of a gate, we devise below a measure of non-simultaneity of switching of the candidate with respect to the other inputs to the gate.

**Definition 2. (Activity Window):** *The activity window of a signal arriving at the input of a gate is the time window bounded by the minimum and the maximum arrival times of the signal at the input of that gate. It is the window within which all the transitions of the signal at the input of that gate can occur.*

**Definition 3. (Critical Windows):** *The critical windows of a signal, $x$, with respect to a signal, $s$, both arriving at the input of a gate, are those segments of the activity window of $x$ that are not overlapping with the activity window of $s$.*

Note that the total duration of the critical windows of a signal with respect to another signal provides a measure on the non-simultaneity in the switching of these two signals at the input of the gate. We use this measure to ascertain approximately what proportion of the glitches in a signal will pass through a gate to which this signal is made an input.

Referring to Fig. 3, the glitching cost of $x$ is taken as amount of glitches in $x$, weighted by the non-simultaneity factor of $x$ w.r.t. the other inputs of $Y$ and the capacitance, $C_{TOTAL}(y)$, which the resulting output glitches have to drive.

The $GlitchingCost_1$ of $x$ driving gate $Y$ is given by the equation:

$$GlitchingCost_1(x, Y) = \alpha(x)\,[D(x) - D_0(x)]\,C_{TOTAL}(y)$$

where:

$$\alpha(x) = \frac{1}{\left|inputs(Y)\right|} \sum_{\substack{s \in \text{ inputs}(Y) \\ s \neq x}} \left( \frac{Total\ Duration\ of\ critical\ windows\ of\ x\ w.r.t.\ s}{Duration\ of\ activity\ window\ of\ x} \right)$$

and where $x$ is the input signal under evaluation, $s$ is another input to the gate $Y$, $C_{TOTAL}(y)$ is the total capacitance at the output node $y$ of the gate, and $D(x)$ and $D_0(x)$ are the total and zero-delay transition densities of $x$.

Fig. 4 illustrates the *rationale* behind this cost function. Of the two candidate signals $x_1$ and $x_2$, note that $D_{x_2} > D_{x_1}$. Nevertheless, it *may be* worthwhile to prefer candidate $x_2$, to $x_1$, for a large proportion of the glitches in $x_1$ occur outside the *activity windows* of other input signals, while most of the switching of $x_2$ occurs simultaneous with some of the other inputs.

Note that, in the above, we are not considering the fact that the gate may be desensitized to an input transition. We will be accounting for that factor in the third part of our power cost function.

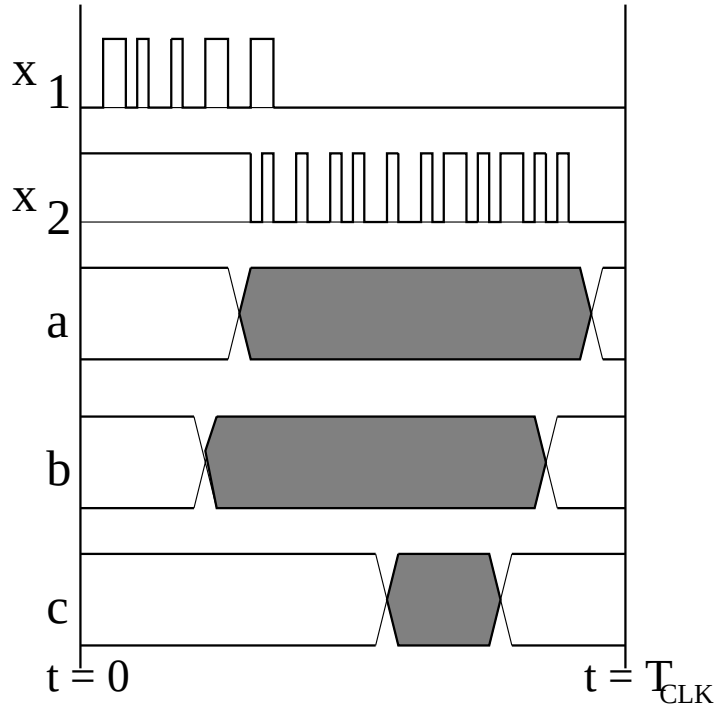


**Figure 4.** Considering Non-simultaneity in Switching for Connection Substitution

*4.1.3 Consideration of Signal Probability with Glitches:*

As the substitutions are chosen with the constraint that the output Boolean functions (and hence the zero-delay activity) of the gates should not change, the differences in the signal probabilities of the candidates would have *no* impact on the zero-delay power at the gate's output. However, they can have a pronounced effect on propagating the input glitches to the gate's output. If the signal probability of a candidate input is such that it sensitizes the gate to the transitions at the other inputs for *unduly* long durations, then the glitch power at the output of the gate can become very large, making this candidate unsuitable for substitution.

As an example, and referring to Fig. 2 again, it is preferable to replace the fanout connection driving the *nand* gate by a signal (from the candidate set) that has the least signal probability (of logic ONE). This is because a low probability at one input of a NAND/AND gate inhibits to a greater extent the transitions at its other inputs from going through. Likewise, for a NOR/OR gate, a high probability is desirable. Thus it is desirable to replace the other fanout connection (driving the *nor* gate) by a candidate having the largest probability.

In general, this strategy applies to any logic gate and aims at reducing the Boolean difference probabilities, which contribute to the propagation of transitions in the circuit [1].

This notion leads to the third cost factor, viz., the $GlitchingCost_2$.

$$GlitchingCost_2(x, Y) \;=\; \left|P(x) - \hat{P}(x)\right| \times [D(y) - D_0(y)] \times C_{TOTAL}(y)$$

where $x$ is the input signal under evaluation, $y$ is the output node of $Y$, $D(y)$ and $D_0(y)$ are the total and zero-delay transition densities of the output node, $C_{TOTAL}(y)$ is the total capacitance of the output node, $P(x)$ is the signal probability of $x$ and $\hat{P}(x)$ is the desired probability for the input terminal of $x$. The desired probability is either 0 or 1, depending on the type of the gate (nand, nor, aoi etc.) and the input pin. If the gate is an *xor/xnor*, then this term of the power cost is not considered, as in such a case the gate remains sensitive to input transitions all the time. Note that, in the above expression, we take the output glitches to approximate the sum of glitches in the input nodes other than $x$.

*4.1.4 Consideration of Residual Redundancy:*

Although we carry out the connection changes on an already optimized circuit, we may not want to rule out the possibility of residual redundancies at the post-mapping stage.

If, by removing a redundant input to a gate, we change the output function of that gate and possibly the functions at its transitive fanouts, then the total zero-delay power of the network can change in an unpredicatable manner. However, if the removal does not cause change of Boolean functions at any node, then we are at least assured of a reduction in the total zero-delay activity of the network. As this is exactly what we guarantee by using LSPF, then removal of redundancies in this way may help to reduce the total power consumed in the circuit.

Similarly, removal of any redundant gate, after all its fanouts are substituted, is also likely to reduce the total power. The only other consideration, possibly outweighing the reduction in zero-delay power, is the change in the glitching power. But, we do consider this factor in the second and third cost factors. For these reasons, we make the connection substitutions more attractive, by considering the opportunity cost of removal of a gate after all its fanouts are substituted.

Consider Fig. 2 again. Suppose we were able to replace one of the fanouts of *gate* 1 with an attractive alternative. If the second fanout connection also has an alternative (though not attractive), it means that *gate* 1 is redundant in the circuit. However, it can not be eliminated before the other fanout is substituted. To help the process of eliminating the redundant *gate* 1 , we make the fanout substitutions more attractive, by considering a larger capacitance load in the *LoadingCost* term of the cost function. As a heuristic, we include the drain capacitance of *gate* 1 in the *LoadingCost* term to reflect the opportunity cost of eliminating *gate* 1.

### 4.2 Algorithm

The procedure of changing the connections configuration is applied iteratively to the network, until the total power of the network shows no further improvement. Each iteration attempts to substitute the fanout connections beginning from the output nodes and sweeping towards the primary inputs. The capacitances at the nodes, the arrival times and the level information are calculated during each iteration. The transition densities at the nodes are estimated through statistical simulation [15] at the beginning of each iteration. The signal probabilities of the nodes are calculated just once at the beginning of the procedure, using the BDDs of the global functions at the nodes. As no new nodes are added and no Boolean function in the network is changed during the iterations, the probability values calculated at the beginning hold good throughout the procedure. The algorithm is given in Fig. 5, below.

**Algorithm. (Post-Mapping Transformation)**

Calculate signal probability ($\mathbf{P(i)}$) of every node **i**
Set MinTotalPower := $\infty$
**while** (T) {
  Levelize Network
  Calculate MinArrival and MaxArrival for every node
  Simulate density & power at all nodes using [15]

  if($NetworkPower \geq MinTotalPower$) **EXIT**
  Set MinTotalPower := NetworkPower
  Accept current network as the best
  foreach node (**i**)
    foreach fanout connection ($C_{ik}$) of **i**
      Calculate LSPF of $C_{ik}$
      MinCost($C_{ik}$) := PowerCost(**i**,**k**)
      Set BestCandidate($C_{ik}$) := **i**
    foreach node (**j**) such that $Level(\mathbf{j}) \leq Level(\mathbf{i})$
                or $MaxArrival(\mathbf{j}) < MinArrival(\mathbf{i})$
      foreach fanout connection ($C_{ik}$) of **i**
        if $F(\mathbf{j}) \in LSPF(C_{ik})$ and $PowerCost(\mathbf{j},\mathbf{k}) \leq MinCost(C_{ik})$
          set MinCost($C_{ik}$) := PowerCost(**j**,**k**)
          set BestCandidate($C_{ik}$) = **j**
    Replace fanout connections of **i** by respective best candidates
}

**Figure 5.** Post-mapping transformation algorithm.

## 5. Experimental Results

For evaluation of our above algorithm, we started with circuits that were already well optimized using the *rugged.script* of the SIS optimizer. For a number of benchmark circuits, two sets of circuit implementations were generated: *reference* circuits, and *study* circuits. The *reference* circuits were obtained using the balanced-tree technology decomposition of SIS and later mapping for optimum area (or delay), also using the SIS mapper. The SIS *lib2.genlib* library was used for mapping. In the *study* circuits, the technology decomposition was done using the algorithm given in [11]. Then, these circuits were mapped, also for area (or delay) in the same manner as the *reference* circuits. The transformation procedure in Section 4.2 was later applied to these circuits. The *reference* and *study* circuits were then simulated for power estimation, using the statistical power estimator, MED [15]. Circuits were simulated with input signals of probability 0.5 and transition density of 0.5 transitions/clock. The simulation was done till the total power of the circuit converged to an error bound of 2% with a confidence of 95%.

TABLE 2

EVALUATION OF DECOMPOSITION AND POST-MAPPING TRANSFORMATIONS

(FOR MIN. AREA MAPPED CIRCUITS)

| CIRCUIT NAME | SIZE #GATES | REFERENCE POWER $\mu$W/MHz | % REDUCTION DUE TO LP Tech. Decomp. | | | LP Post-Mapping | | | TOTAL Power Reduction % |
|---|---|---|---|---|---|---|---|---|---|
| | | | Pwr | Dly | Area | Pwr | Dly | Area | |
| apex7 | 249 | 6.650 | 6.1 | 0.9 | 0.4 | 0.2 | 9.4 | 2.1 | 6.3 |
| example2 | 296 | 12.314 | 5.7 | 3.6 | -0.2 | 0.1 | -5.8 | 0.0 | 5.8 |
| x4 | 352 | 11.424 | 1.9 | -1.6 | 0.7 | 0.6 | -0.7 | 0.3 | 2.5 |
| x1 | 368 | 13.533 | 11.2 | 10.4 | -0.7 | 2.5 | 9.1 | 1.9 | 13.7 |
| alu2 | 383 | 19.622 | 11.1 | -11.7 | -14.5 | 8.1 | 27.7 | 3.4 | 19.2 |
| vda | 500 | 24.440 | -3.9 | -15.2 | -0.8 | 2.9 | 0.5 | 0.7 | -1.0 |
| i9 | 539 | 18.259 | 15.5 | 3.0 | -1.7 | 11.3 | 22.4 | 0.9 | 26.8 |
| alu4 | 739 | 37.022 | 13.3 | 16.0 | -0.3 | 4.4 | 11.1 | 3.0 | 17.7 |
| rot | 838 | 36.275 | 2.8 | -6.9 | 1.0 | *** | *** | *** | 2.8 |
| x3 | 923 | 30.459 | 2.8 | 8.7 | 0.4 | 12.1 | 21.2 | 5.9 | 14.9 |
| t481 | 978 | 23.760 | 9.6 | -11.4 | -0.2 | 7.6 | 4.5 | 5.1 | 17.2 |
| i8 | 1100 | 57.630 | 57.9 | 37.3 | 7.9 | 0.9 | 1.6 | 0.8 | 58.8 |
| Average | | | 13.2 | 2.8 | -0.7 | 4.8 | 9.2 | 2.2 | 15.4 |

Table 2 pertains to the circuits that were mapped for optimum area and Table 3 to the circuits that were mapped for minimum delay. Column 2 of the tables shows the relative size of the circuits, using the number of gates in the 2-input nand/nor implementation. Column 3 is the power consumption of the *reference* circuits in $\mu$W/MHz. Columns 4, 5 and 6 show the percentage reduction in power, delay and the area of the circuit, as a result of application

of our low-power technology decomposition algorithm [15]. Similarly, further reduction in power, delay and area achieved by the post-mapping transformation are shown in Columns 7, 8 and 9. Finally, column 10 shows the total power reduction. A negative number in these tables means an increase in area/delay/power.

Except on one circuit (*vda*), the technology decomposition did well on all the area mapped circuits, achieving an average of 13.2% reduction in power and 2.8% reduction in delay, with very little penalty on area. Larger power savings were recorded by large circuits, for example the power consumption of *i8* decreased by almost 58%. In the case of delay mapped circuits, the technology decomposition reduced power on an average by 6.5%, delay 4.5% and area 1.2%. Again, *i8* recorded the maximum gains, viz., 28.7% in power, 14.4% in delay and 7.1% in area. For a comparison, [8] reported that their decomposition algorithm resulted in a reduction of 3.6% in power. For a few circuits (*vda* in Table 2 and *example2, x4, x3* in Table 3) the power increased with our decomposition. This is due to the sub-optimality of the algorithm.

TABLE 3

EVALUATION OF DECOMPOSITION AND POST-MAPPING TRANSFORMATIONS

(FOR MIN. DELAY MAPPED CIRCUITS)

| CIRCUIT NAME | SIZE #GATES | REFERENCE POWER $\mu$W/MHz | % REDUCTION DUE TO LP Tech. Decomp. | | | LP Post-Mapping | | | TOTAL Power Reduction % |
|---|---|---|---|---|---|---|---|---|---|
| | | | Pwr | Dly | Area | Pwr | Dly | Area | |
| apex7 | 249 | 12.994 | 8.5 | 7.4 | -0.8 | 1.3 | -1.0 | 0.0 | 9.8 |
| example2 | 296 | 14.167 | -9.3 | 48.2 | 1.9 | 11.1 | 0.6 | 2.8 | 1.8 |
| x4 | 352 | 17.147 | -2.1 | -4.7 | 2.2 | 0.3 | 2.0 | 0.3 | -1.8 |
| x1 | 368 | 23.136 | 7.7 | -3.6 | 0.7 | 4.8 | -1.7 | 2.6 | 12.5 |
| alu2 | 383 | 25.743 | 3.3 | 3.5 | -3.6 | 12.7 | 17.8 | 7.8 | 16.0 |
| vda | 500 | 29.876 | 10.3 | 2.3 | 2.8 | 2.5 | 7.8 | 2.3 | 12.8 |
| i9 | 539 | 42.602 | 9.8 | -22.1 | -2.5 | 7.4 | -7.4 | 0.9 | 17.2 |
| alu4 | 739 | 53.215 | 17.5 | -0.3 | 0.9 | 5.0 | 9.8 | 3.2 | 22.5 |
| rot | 838 | 57.159 | 3.3 | 1.6 | 1.3 | *** | *** | *** | 3.3 |
| x3 | 923 | 52.319 | -1.9 | 15.8 | 2.1 | 12.4 | -27.2 | 7.5 | 10.5 |
| t481 | 978 | 27.603 | 1.8 | -8.4 | 2.2 | 11.4 | 6.9 | 6.6 | 13.2 |
| i8 | 1100 | 76.115 | 28.7 | 14.4 | 7.1 | 9.6 | 0.8 | 4.4 | 38.3 |
| Average | | | 6.5 | 4.5 | 1.2 | 7.1 | 0.8 | 3.5 | 13.0 |

The post-mapping transformation achieved a power reduction of 4.8% and 7.1% (on average) for the area-mapped and delay-mapped circuits respectively. This power reduction is over and above the power reduction achieved by our low-power technology decomposition algorithm, demonstrating the fact that the post-mapping optimization is augmenting the the power optimization done at the technology decomposition stage. The area and delay of

the circuits also decreased substantially as a result of the post-mapping transformations.

The effectiveness of the post-mapping transformation in handling both the zero-delay power, as well as the glitch power, has been brought out in Table 4. Column 2 of the table shows the power dissipation due to glitches, as a percentage of the total dynamic power. Columns 3 and 4 show the percentage reduction in zero-delay power and the percentage reduction in glitching power respectively. Column 5 shows the percentage reduction in area. The figures given in that table are for delay mapped circuits.

TABLE 4

DETAILED ANALYSIS OF POST-MAPPING TRANSFORMATION RESULTS

(FOR MIN. DELAY MAPPED CIRCUITS)

| CIRCUIT NAME | Glitch Power (as %TotalPwr) | %Reduction in zdPower | %Reduction in Glitch Power | %Reduction in Area |
|---|---|---|---|---|
| apex7 | 11.8 | 0.0 | 11.0 | 0.0 |
| example2 | 17.4 | 8.4 | 23.9 | 2.8 |
| x4 | 15.7 | 0.5 | -0.8 | 0.3 |
| x1 | 11.6 | 3.5 | 14.7 | 2.6 |
| alu2 | 27.2 | 10.3 | 19.1 | 7.8 |
| vda | 23.0 | 3.2 | 0.2 | 2.3 |
| i9 | 28.8 | 4.1 | 15.6 | 0.9 |
| alu4 | 33.8 | 5.6 | 3.8 | 3.2 |
| x3 | 19.5 | 11.8 | 14.9 | 7.5 |
| t481 | 18.5 | 9.8 | 18.5 | 6.6 |
| i8 | 25.2 | 12.9 | 0.0 | 4.4 |
| Average | 21.1 | 6.4 | 11.0 | 3.5 |

We can make the following observations from the table:

(*i*) It can be seen that the glitching power constitutes a considerable fraction of the total power. It is as high as 34% in some circuits(*alu4*). This reiterates the point that ignoring the glitching power in a synthesis system for power can seriously affect the optimality of the results.

(*ii*) Column 3 of Table 4 shows an average reduction of 6.4% in zero-delay power, as against only 3.4% reduction in area (column 5). This was made possible by considering the LoadingCost of the candidate substitutions and shifting the loads from highly transitioning nodes to nodes with low transition density.

(*iii*) Similarly, a comparison of column 4 with column 5 shows the effectiveness of the glitching cost considerations made by the algorithm. There are several examples in the Table (*apex7, example2, x1, alu2 and t481*) for which the reduction in glitching power is much higher than the reduction in area. For instance, *example2* recorded a reduction of 23.9% reduction in glitch power as against only a 2.8% reduction in area. This implies that

the bulk of reduction in glitch power was realized by the reduction of the total glitching activity in the circuit, than by the reduction of the capacitances in the circuit.

(*iv*) There are also few examples (*x4 and i8*) for which the algorithm had no or negative effect on glitches. This is possibly caused by the inexactness of the heuristic measure that considers the non-simultaneity in the switching of signals, viz. the *critical windows*, and also due to the presence of false paths that artificially expand the activity windows of signals.

As the complexity of our technology decomposition algorithm is $\mathcal{O}(n \log n)$, it takes only a few seconds on a Sun Sparc-10 workstation. Furthermore, as the Boolean functions and the permissible functions are represented in BDD structures in our system, and since the checking of candidate functions w.r.t. the permissible functions involves implication checks which are very efficiently implemented on BDDs, our post-mapping algorithm is also quite fast. The post-mapping algorithm completed in 2 to 5 iterations in all the circuits that we tested. The largest circuit, viz., *i8* took 953 and 873 CPU seconds for the area and delay mapped circuits respectively, on a Sun Sparc-10 workstation.

## 6. Summary and Conclusions

We have presented a methodology for low-power synthesis, wherein we structure the circuit for minimum activity during the technology decomposition stage and perform change of connections configuration in a post-mapping phase. We have shown the effectiveness of these algorithms through test results on a number of benchmark circuits. The procedure performs very well in reducing both the zero-delay and the glitching components of power.

The idea of making detailed considerations of *transition density*, *signal probability*, *arrival times* and *glitching transitions* of a signal to minimize the circuit power are *unique* to our approach and this approach can be extended also to other post-mapping transformations, like resynthesis and merging of gates. We are currently working on such extensions.

## Appendix

### Permissible Functions

We briefly review the concept of a permissible function [3], which is at the core of our transformations.

**Definition 1. (Permissible Function):** *A function $f$ is said to be a permissible function of a gate or connection if replacing the function realized at the output of the gate or at the connection by the function $f$ does not cause any primary output of the network to realize an incorrect function.*

The Set of Permissible Functions (SPF) at a node or connection can be represented using any two of the ON-, OFF-, and the DC-Sets of vertices for that node/connection. In this work, we will use the on-, and off-sets of a node in a BDD structure to represent the permissible functions:

$$\text{SPF}(x) = \left[G^{ON}(x), G^{OFF}(x)\right]$$

where the $G^{ON}$ and $G^{OFF}$ are collections of minterms and maxterms of $x$ respectively.

In our post-mapping transformations, we use a subset of the maximal set of permissible functions, known as the *locally-derived set of permissible functions* [17], abbreviated as LSPF. The LSPF has a property that implementing any of the functions in the LSPF of a node or connection, at that node or connection, will not change the Boolean function of the nodes lying in the transitive fanouts of that node or connection. The LSPF is particularly attractive for post-mapping transformations, as we have shown.

If $x$ is an input connection to a gate whose output function in terms of local variables is $y$, then it can be shown that the LSPF of the connection $x$ with respect to its output $f$ is:

$$\text{LSPF}(x) = \left[F(x)\frac{\partial y}{\partial x}, \overline{F}(x)\frac{\partial y}{\partial x}\right]$$

where $x$ is the Boolean variable of the connection $x$, $F(x)$ is the Boolean function of $x$ and $\partial y/\partial x$ is the Boolean Difference of $y$ w.r.t. $x$, defined as:

$$\frac{\partial y}{\partial x} = y|_{x=0} \oplus y|_{x=1}$$

where $\oplus$ is the exclusive-or function.

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